

<b>Notice of References Cited</b>	Application/Control No. 10/575,706		Applicant(s)/Patent Under Reexamination VAANANEN ET AL.	
	Examiner THUAN NGUYEN		Art Unit 4145	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0231594 A1	12-2003	Xu et al.	370/236
*	C	US-2004/0258072 A1	12-2004	Deforche, Koen	370/395.4
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**NON-PATENT DOCUMENTS**

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